

August 2001 Revised August 2001

FIN1531 5V LVDS 4-Bit High Speed Differential Driver

General Description

This quad driver is designed for high speed interconnects utilizing Low Voltage Differential Signaling (LVDS) technology. The driver translates 5V TTL/CMOS signal levels to LVDS levels with a typical differential output swing of 350 mV which provides low EMI at ultra low power dissipation even at high frequencies. This device is ideal for high speed transfer of clock and data.

The FIN1531 can be paired with its companion receiver, the FIN1532, or with any other Fairchild LVDS receiver.

Features

- Greater than 400Mbs data rate
- 5V power supply operation
- 400ps max differential pulse skew
- 2.0ns maximum propagation delay
- Low power dissipation
- Power-Off protection
- Meets or exceeds the TIA/EIA-644 LVDS standard
- Pin compatible with equivalent RS-422 and PECL devices
- 16-Lead SOIC and TSSOP packages save space

Ordering Code:

Order Number	Package Number	Package Description			
FIN1531M	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow			
FIN1531MTC	MTC16	16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide			

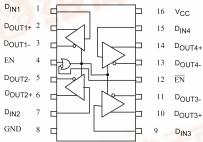
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Function Table

	Input	Outputs		
EN	EN	D _{IN}	D _{OUT+}	D _{OUT}
Н	Х	Н	Н	
Н	X	L	_460	Н
Н	X	OPEN	In I	Н
X	-L	Н	Н	L
X	L	L	L	Н
X	L	OPEN	L	Н
L	Н	Х	Z	Z

H = HIGH Logic Level X = Don't Care L = LOW Logic Level Z = High Impedance

Connection Diagram



Pin Descriptions

Pin Name	Description		
D _{IN1} , D _{IN2} , D _{IN3} , D _{IN4}	5V TTL/CMOS Data Input		
D _{OUT1+} , D _{OUT2} +, D _{OUT3+} , D _{OUT4+}	Non-inverting LVDS Output		
D _{OUT1-} , D _{OUT2-} , D _{OUT3-} , D _{OUT4-}	Inverting LVDS Output		
EN	Driver Enable Pin		
EN	Inverting Driver Enable Pin		
V _{cc}	Power Supply		
GND	Ground		



Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions

 $\begin{array}{lll} \mbox{Supply Voltage (V}_{\mbox{CC}}) & -0.5\mbox{V to +6V} \\ \mbox{DC Input Voltage (V}_{\mbox{IN}}) & -0.5\mbox{V to +6V} \\ \end{array}$

 $\begin{array}{ll} \text{DC Output Voltage (V}_{\text{OUT}}) & -0.5 \text{V to } +6 \text{V} \\ \text{Driver Short Circuit Current (I}_{\text{OSD}}) & \text{Continuous} \\ \text{Storage Temperature Range (T}_{\text{STG}}) & -65 ^{\circ} \text{C to } +150 ^{\circ} \text{C} \\ \end{array}$

Max Junction Temperature (T_J)

Lead Temperature (T_L)

(Soldering, 10 seconds) 260°C

ESD (Human Body Model) ≥ 8000V

ESD (Machine Model) ≥ 400V

Note 1: The "Absolute Maximum Ratings": are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature and output/input loading variables. Fairchild does not recommend operation of circuits outside databook specification.

DC Electrical Characteristics

Over supply voltage and operating temperature ranges, unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ (Note 2)	Max	Units
V _{OD}	Output Differential Voltage		250	350	450	mV
ΔV_{OD}	V _{OD} Magnitude Change from	RL = 100Ω, driver enabled,			25	mV
	Differential LOW-to-HIGH	See Figure 1			23	IIIV
Vos	Offset Voltage	7	1.125	1.25	1.375	V
ΔV _{OS}	Offset Magnitude Change from Differential LOW-to-HIGH				25	mV
I _{OFF}	Power Off Output Current	V _{CC} = 0V, V _{OUT} = 5.5V			50	μА
Ios	Short Circuit Output Current	V _{OUT} = 0V, Driver Enabled			-6	mA
		V _{OD} = 0V, Driver Enabled			±6	IIIA
V _{IH}	Input HIGH Voltage		2.0		V _{CC}	V
V _{IL}	Input LOW Voltage		GND		0.8	V
I _{IN}	Input Current	$V_{IN} = 0V$ or V_{CC}			±20	μΑ
I _{I(OFF)}	Power-OFF Input Current	$V_{CC} = 0V, V_{IN} = 5.5V$			50	μΑ
I _{OZ}	Disabled Output Leakage Current	$EN = 0.8V, \overline{EN} = 2.0V,$ $V_{OUT} = 0V \text{ or } 7V$			±20	μА
V _{IK}	Input Clamp Voltage	I _{IK} = -18 mA	-1.5	-0.8		V
I _{CC}	Power Supply Current	No Load, V _{IN} = 0V or V _{CC} , Driver Enabled		3.3	6	
		$R_L = 100\Omega$, Driver Disabled		3.4	6	mA
		$R_L = 100\Omega$, $V_{IN} = 0V$ or V_{CC} , Driver Enabled		18	26	
C _{IN}	Input Capacitance			7		pF
C _{OUT}	Output Capacitance			4.5		pF

150°C

Note 2: All typical values are at $T_A = 25$ °C and with $V_{CC} = 5.0$ V.

AC Electrical Characteristics

Over supply voltage and operating temperature ranges, unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ (Note 3)	Max	Units
t _{PLHD}	Differential Propagation Delay LOW-to-HIGH		0.5	1.4	2.0	ns
t _{PHLD}	Differential Propagation Delay HIGH-to-LOW	$R_L = 100 \Omega$, $C_L = 10 pF$,	0.5	1.4	2.0	ns
t _{TLHD}	Differential Output Rise Time (20% to 80%)	See Figure 2 and Figure 3 (Note 7)	0.6	0.8	1.2	ns
t _{THLD}	Differential Output Fall Time (80% to 20%)		0.6	0.8	1.2	ns
t _{SK(P)}	Pulse Skew t _{PLH} - t _{PHL}				0.4	ns
t _{SK(LH)} , t _{SK(HL)}	Channel-to-Channel Skew (Note 4)				0.3	ns
t _{SK(PP)}	Part-to-Part Skew (Note 5)				1.0	ns
f _{MAX}	Maximum Frequency(Note 6)		200	250		ns
t _{ZHD}	LVTTL Output Enable Time from Z to HIGH	$R_L = 100\Omega, C_L = 10 pF,$			5.0	ns
t _{ZLD}	LVTTL Output Enable Time from Z to LOW	See Figure 4 and Figure 5 (Note 7)			5.0	ns
t _{HZD}	LVTTL Output Disable Time from HIGH to Z				5.0	ns
t _{LZD}	LVTTL Output Disable Time from LOW to Z				5.0	ns

Note 3: All typical values are at $T_A = 25$ °C and with $V_{CC} = 5$ V.

Note 4: $t_{SK(LH)}$, $t_{SK(HL)}$ is the skew between specified outputs of a single device when the outputs have identical loads and are switching in the same direction.

Note 5: $t_{SK(PP)}$ is the magnitude of the difference in propagation delay times between any specified terminals of two devices switching in the same direction (either LOW-to-HIGH or HIGH-to-LOW) when both devices operate with the same supply voltage, same temperature, and have identical test circuits.

Note 6: f_{MAX} Criteria: Input $t_R = t_F < 1$ ns, 0V to 3V, 50% Duty Cycle; Output $V_{OD} > 250$ mV, 45% to 55% Duty Cycle; all output channels switching in phase.

Note 7: Test Circuits in Figure 2 and Figure 4 are simplified representations of test fixture and DUT loading.

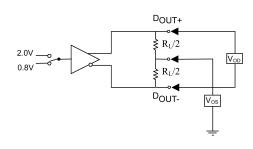
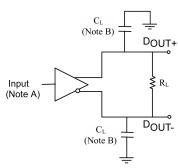


FIGURE 1. Differential Driver DC Test Circuit



 $\begin{tabular}{ll} \textbf{Note A:} & \textbf{Input pulses have frequency} = 10 \ \textbf{MHz}, \ t_R \ \textbf{or} \ t_F = 1 \ \textbf{ns} \\ \begin{tabular}{ll} \textbf{Note B:} \ \textbf{C}_L \ \textbf{includes} \ \textbf{all probe and jig capacitances} \\ \end{tabular}$

FIGURE 2. Differential Driver Propagation Delay and Transition Time Test Circuit

 D_{OUT+} $R_{L}/2$

 $rac{1}{2}$ $R_L/2$

D_{OUT}-

 C_{L}

C_L (Note B)

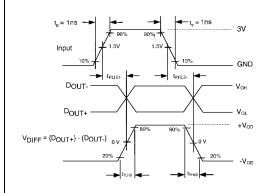
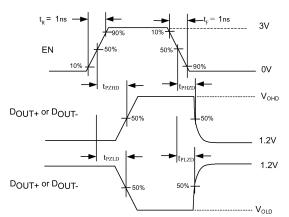


FIGURE 3. AC Waveforms

Note A: Input pulses have the following characteristics: Frequency = 10 MHz, t_R or $t_F = 1$ ns

Note B: C_L includes probes and jig capacitance

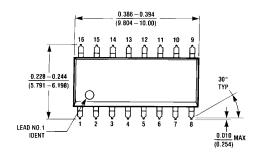
FIGURE 4. Differential Driver Enable and Disable Test Circuit

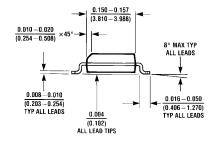


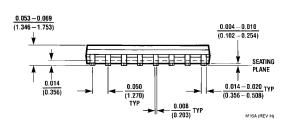
Input

FIGURE 5. Enable and Disable AC Waveforms

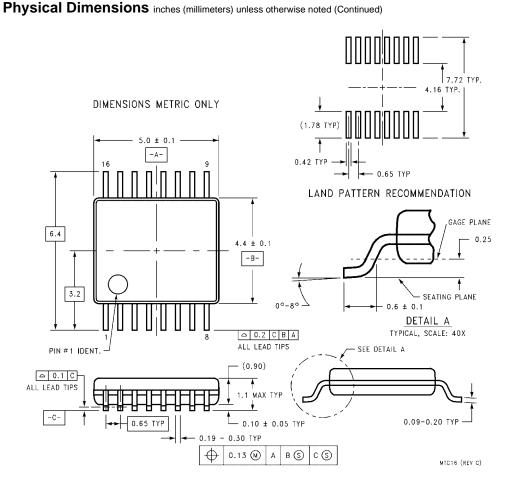
Physical Dimensions inches (millimeters) unless otherwise noted







16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M16A



16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC16

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